# <u>onsemi</u>,

# <u>MOSFET</u> - Power, Single, N-Channel

# **40 V, 4.9 m**Ω, **77 A**

# NVTFS004N04C

## Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS004N04C Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltag	V <sub>DSS</sub>	40	V		
Gate-to-Source Voltage	e		V <sub>GS</sub>	±20	V
Continuous Drain Current $R_{\theta,IC}$	Steady State	$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	77	A
(Notes 1, 2, 3, 4)	Olulo	$T_C = 100^{\circ}C$		43	
Power Dissipation		$T_C = 25^{\circ}C$	PD	55	W
R <sub>θJC</sub> (Notes 1, 2, 3)		$T_C = 100^{\circ}C$		18	
Continuous Drain Current $R_{\theta,IA}$	Steady State	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	18	А
(Notes 1, 3, 4)	State	$T_A = 100^{\circ}C$		13	
Power Dissipation	$T_A = 25^{\circ}C$		PD	3.2	W
$R_{\theta JA}$ (Notes 1, 3)		$T_A = 100^{\circ}C$		1.6	
Pulsed Drain Current	$T_A = 25^\circ$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	338	А
Operating Junction and Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C		
Source Current (Body D	I <sub>S</sub>	45.5	А		
Single Pulse Drain–to–S Energy (I <sub>L(pk)</sub> = 5.2 A)	E <sub>AS</sub>	122	mJ		
Lead Temperature for S (1/8" from Case for 10 s	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\thetaJA}$	47.4	

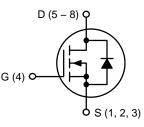
1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

- 2. Psi ( $\Psi$ ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
40 V	4.9 mΩ @ 10 V	77 A	

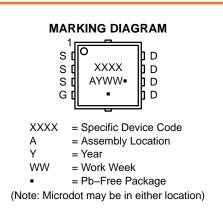
N-Channel



WDFN8 3.3x3.3, 0.65P CASE 511AB



#### WDFNW8 3.3x3.3, 0.65P (Full-Cut µ8FL WF) CASE 515AN



# **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

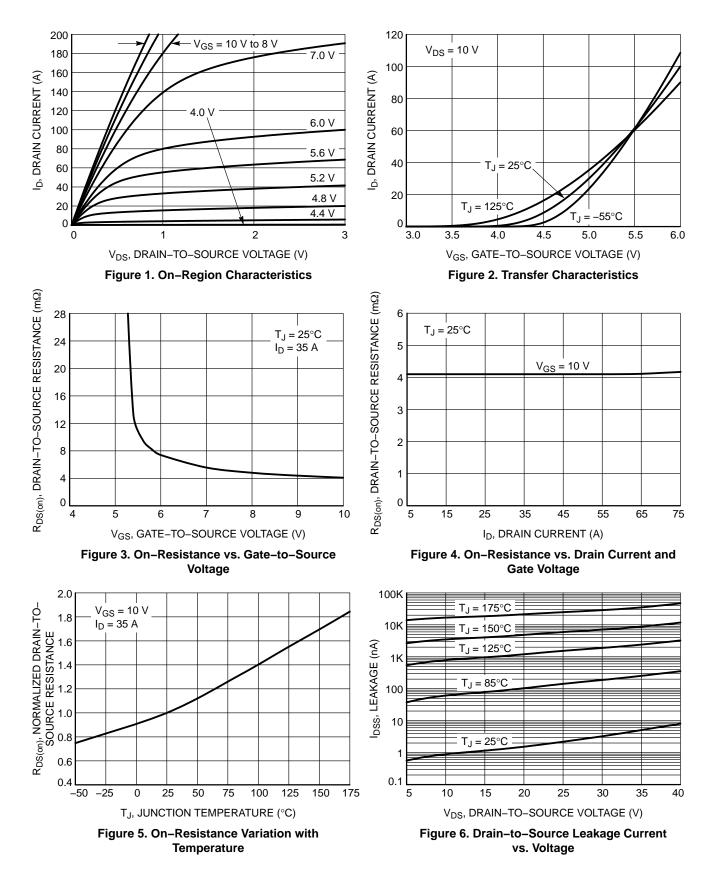
1

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

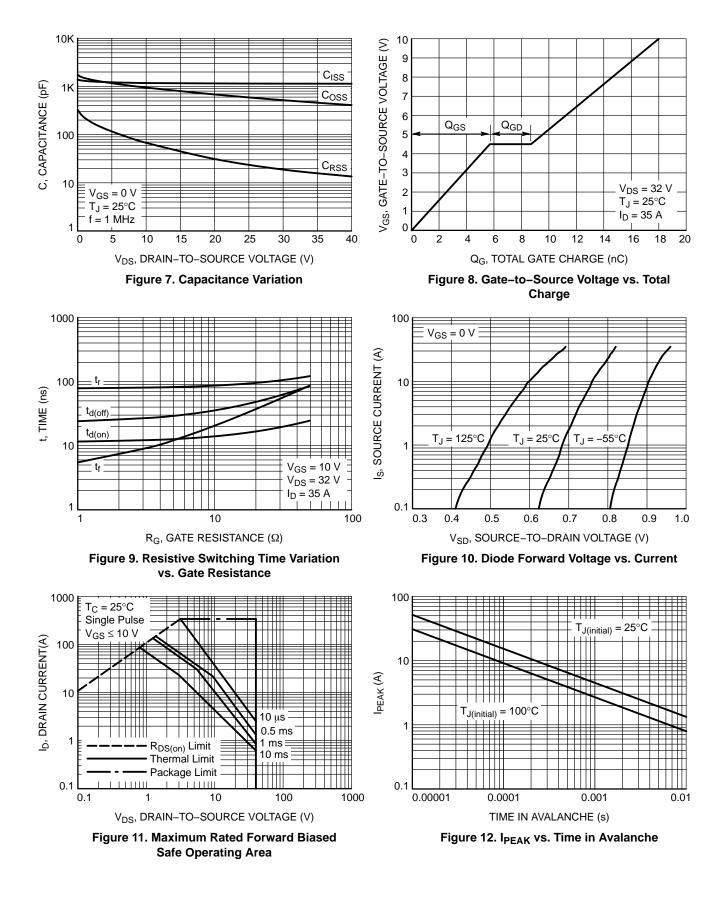
Parameter	Symbol	Test Cor	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 25$	0 μΑ	40	-	_	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	-	-	10	μΑ
		$V_{DS} = 40 \text{ V}$	$T_J = 125^{\circ}C$	-	-	250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = 2$	20 V	-	-	100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 50$	) μΑ	2.5	-	3.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 3$	5 A	-	4.1	4.9	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 3	5 A	-	57	-	S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V, f = 1.0$	MHz,	-	1150	_	pF
Output Capacitance	C <sub>oss</sub>	$V_{\rm DS} = 25 V$		_	600	_	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	25	_	
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 32 V, $I_{D}$ = 35 A		-	3.7	_	nC
Gate-to-Source Charge	Q <sub>GS</sub>			-	5.7	-	1
Gate-to-Drain Charge	Q <sub>GD</sub>			-	3.0	_	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 32 V, $I_{D}$ = 35 A		-	18	-	nC
SWITCHING CHARACTERISTICS (No	te 6)						
Turn–On Delay Time	t <sub>d(on)</sub>	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} =$	32 V,	-	12	_	ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 35 A		_	80	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	1		_	26	_	1
Fall Time	t <sub>f</sub>	1		_	8	_	1
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	-	0.82	1.2	V
	او	I <sub>S</sub> = 35 A	T <sub>J</sub> = 125°C	-	0.69	_	1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 V, dI_S/dt = 100 A/\mu s,$ $I_S = 35 A$		-	33	_	ns
Charge Time	t <sub>a</sub>			-	16	_	1
Discharge Time	t <sub>b</sub>			_	17	_	1
Reverse Recovery Charge	Q <sub>RR</sub>			_	18	_	nC

5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**



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# **TYPICAL CHARACTERISTICS**

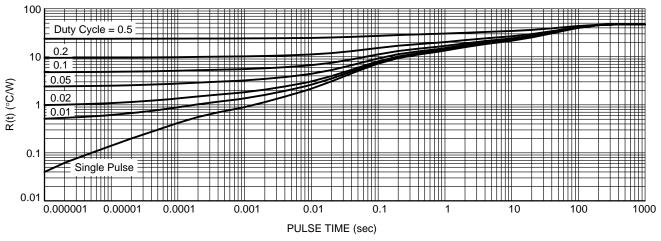


Figure 13. Thermal Characteristics

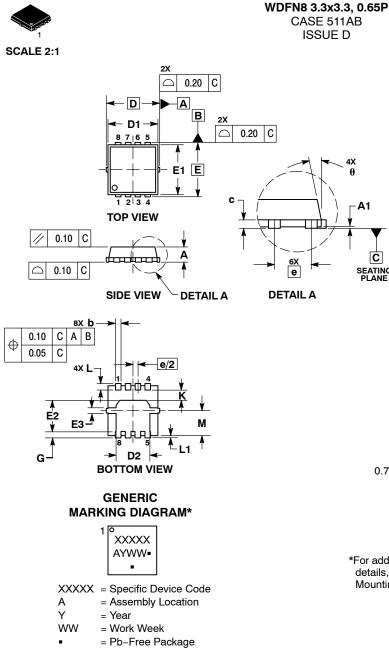
### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS004N04CTAG	04NC	WDFN8 3.3x3.3, 0.65P (Pb–Free)	1500 / Tape & Reel
NVTFWS004N04CTAG	04NW	WDFNW8 3.3x3.3, 0.65P (Full–Cut µ8FL WF) (Pb–Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# DURSEU

DATE 23 APR 2012



\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES:

**A1** 

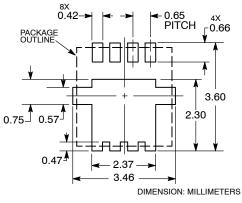
C

SEATING PLANE

- LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.
- 3.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D	;	3.30 BSC		0	.130 BSC	)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
Е	:	3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
к	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

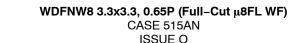
SOLDERING FOOTPRINT\*



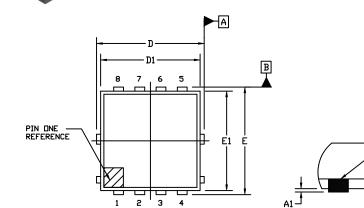
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DATE 25 AUG 2020



TOP VIEW

DETAIL A

SIDE VIEW

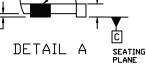
// 0.10 C

-4X L

E3] E2

Ŀ

0.10 C



MOLD COMPOUND AT BOTTOM OF TIE BAR

REMAIN

NDTES:

PLATED AREA

з.

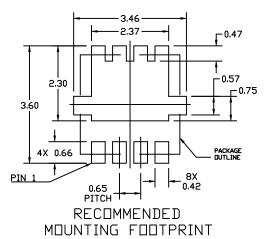
	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
Α	0.70	0.75	0.80	
A1	0.00		0.05	
ø	0.23	0.30	0.40	
с	0.15	0.20	0.25	
D	3.05	3.30	3.55	
D1	2.95	3.05	3.15	
D2	1.98	2.11	2.24	
E	3.05	3.30	3.55	
E1	2.95	3.05	3.15	
E2	1.47	1.60	1.73	
E3	0.23	0.30	0.40	
e	0.65 BSC			
G	0.30	0.41	0.51	
к	0.65	0.80	0.95	
L	0.30	0.43	0.59	
L1	0.06	0.13	0.20	
м	1.40	1.50	1.60	

1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH,

2. CONTROLLING DIMENSION: MILLIMETERS

PROTRUSIONS, OR GATE BURRS.



For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC **MARKING DIAGRAM\*** 

XXXX

AYWW=

BOTTOM VIEW

XXXX = Specific Device Code = Assembly Location

Υ = Year

8X b

L1-

DETAIL B

⊕ 0.10 @ C A B
0.05 @ C

- WW = Work Week

= Pb-Free Package

DETAIL B

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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